DELIVERY SPECIFICATION

SPEC. No.

D A T E: Sep., 2025

То

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

Multilayer Ceramic Chip Capacitors
Low ESL Reverse Geometry

Tape packaging 【RoHS2 compliant】

C0510 Type

X5R,X6S,X7R,X7S Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

SCOPE

This delivery specification shall be applied to Multilayer ceramic chip capacitors to be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $\underline{C} \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \Delta \Box \Box \Box \times$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of surface
	mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

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<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

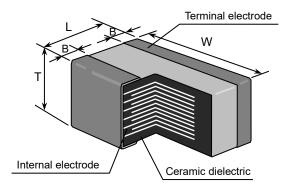
If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	September, 2025	

1. CODE CONSTRUCTION

(Example) $\frac{\text{C0510}}{\text{(1)}}$ $\frac{\text{X5R}}{\text{(2)}}$ $\frac{\text{1C}}{\text{(3)}}$ $\frac{\text{104}}{\text{(4)}}$ $\frac{\text{M}}{\text{(5)}}$ $\frac{\text{T}}{\text{(6)}}$ $\frac{\text{OOOO}}{\text{(7)}}$

(1) Case size



Case size	Dimensions (Unit : mm)				
[EIA style]	L	W	Т	В	
C0510 [CC0204]	0.52 ± 0.05	1.00 ± 0.05	0.30 ± 0.05	0.10 min.	

^{*} As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

(3) Rated Voltage

Symbol	Rated Voltage		
1 H	DC 50 V		
1 E	DC 25 V		
1 C	DC 16 V		
1 A	DC 10 V		
0 J	DC 6.3 V		
0 G	DC 4 V		
0 E	DC 2.5 V		

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

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Symbol	Rated Capacitance				
104	100,000 pF				

(5) Capacitance tolerance

Symbol	Tolerance
М	± 20 %
Symbol	Packaging

Taping

(6) Packaging

-\ -						

(7) TDK internal code

^{*} Details are shown in table 1 No.6 at 6.PERFORMANCE

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Temperature Characteristics	Capacitance tolerance	Rated capacitance
X5R X6S X7R X7S	M (± 20 %)	E - 3 series

Capacitance Step in E series

E series	Capacitance Step			
E- 3	1.0	4.7		

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
X6S	-55°C	105°C	25°C
X7R/X7S	-55°C	125°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

6. PERFORMANCE

table 1

No.	Item	Performance	Test or inspection method	
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3×)	
2	Insulation Resistance	10,000M Ω or 500M Ω ·μF min. (As for the capacitors of rated voltage 16V DC and lower, 10,000M Ω or 100M Ω ·μF min.), whichever smaller.	Measuring voltage: Rated voltage Voltage application time: 60s.	
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	Applied voltage : 2.5 times of rated voltage Voltage application time : 1s. Charge / discharge current : 50mA or lower	
4	Capacitance	Within the specified tolerance.	Please contact with our sales representative.	
5	Dissipation Factor	Please refer to detail page on TDK web.	See No.4 in this table for measuring condition.	
6	Temperature Characteristics of Capacitance	Capacitance Change (%) No voltage applied X5R:±15 X6S:±22 X7R:±15 X7S:±22	Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. \[\Delta \text{De calculated ref. STEP3 reading} \] \[\frac{\text{Step}}{2} \] \[\frac{\text{Temperature(°C)}}{2} \] \[\frac{25 \pm 2}{2} \] \[\frac{25 \pm 2}{2} \] \[\frac{4}{2} \] \[\text{Max. operating temp. \pm 2} \] As for Max. operating temp, please refer to "3. OPERATING TEMPERATURE RANGE" As for measuring voltage, please contact with our sales representative.	
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix2. Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.board. Pushing force: 2N Holding time: 10±1s	

(continued)

(cont	,		Performance	Test or inspection method
8	Bending	External appearance	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1 and bend it for 1mm. 20 Reflow solder the capacitors on a P.C.Board shown in Appendix 1 and bend it for 1mm. (Unit : mm)
9	Solderability		New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material. A section	Solder: Sn-3.0Ag-0.5Cu Flux: Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. Solder temp.: 245±5°C Dwell time: 3±0.3s. Solder Until both terminations are position: completely soaked.
10	Resistance to solder heat	External appearance Capacitance	No cracks are allowed and terminations shall be covered at least 60% with new solder. Change from the value before test ± 7.5 %	Solder: Sn-3.0Ag-0.5Cu Flux: Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. Solder temp.: 260±5°C Dwell time: 10±1s. Solder Until both terminations
		D.F. Insulation Resistance Voltage	Meet the initial spec. Meet the initial spec. No insulation breakdown or other	position: are completely soaked. Pre-heating: Temp. — 110~140°C Time — 30~60s. Leave the capacitors in ambient condition for 24±2h before measurement.
11	Vibration	proof External appearance Capacitance	No mechanical damage. Change from the value before test ± 7.5 %	Frequency: 10~55~10Hz Reciprocating sweep time: 1 min. Amplitude: 1.5mm Repeat this for 2h each in 3 perpendicular directions(Total 6h). Reflow solder the capacitors on a
		D.F.	Meet the initial spec.	P.C.Board shown in Appendix2 before testing.

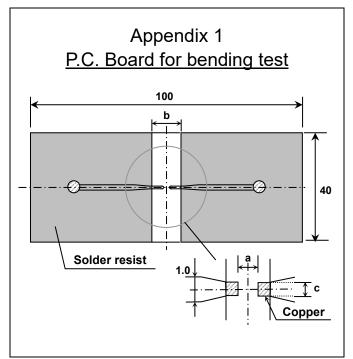
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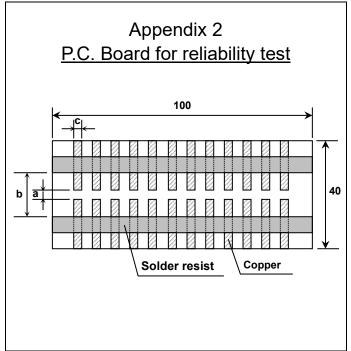
No.	Ite	em	Performance	Test or inspection method			
12	Temperature cycle	External appearance Capacitance	No mechanical damage. Change from the value before test	step1 t	Expose the capacitors in the condition step1 through step 4 listed in the following table. Temp. cycle: 5 cycles		
					<u> </u>	_	
			Please contact with our sales representative.	Step	Temperature(°C)	Time (min.)	
				1	-55 ± 3	30 ± 3	
		D.F.	Meet the initial spec.	2	Ambient Temp.	2 ~ 5	
		Insulation	Meet the initial spec.	3	Max. operating temp.± 2	30 ± 2	
		Resistance Voltage	No insulation breakdown or other	4	Ambient Temp.	2 ~ 5	
		proof	damage.	As for Max. operating temp., please re to "3. OPERATING TEMPERATURE RANGE" Leave the capacitors in ambient condit for 24±2h before measurement. Reflow solder the capacitors on a P.C.Board shown in Appendix2 before		ERATURE nbient condition ment.	
13	Moisture Resistance	External appearance	No mechanical damage.	testing. Test temp.: 40±2°C Test humidity: 90~95%RH Test time: 500 +24,0h Leave the capacitors in ambient co for 24±2h before measurement. Reflow solder the capacitors on a		I	
	(Steady State)	Capacitance	Change from the value before test Please contact with our sales representative.			ment.	
		D.F.	200% of initial spec. max.	P.C.Board shown in Appendix2 befitesting.	ndix2 before		
		Insulation Resistance	1,000MΩ or 50MΩ·μF min. (As for the capacitors of rated voltage 16V DC and lower, 1,000MΩ or 10MΩ·μF min.), whichever smaller.				

(continued)

No.	It	em	Performance	Test or inspection method
14	Moisture Resistance		No mechanical damage.	Test temp.: 40±2°C Test humidity: 90~95%RH Applied voltage: Rated voltage
		Capacitarios	Change from the value before test	Test time: 500 +24,0h Charge/discharge current: 50mA or lowe
			Please contact with our sales representative.	Leave the capacitors in ambient condition for 24±2h before measurement.
		D.F.	200% of initial spec. max.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.
		Insulation Resistance	500MΩ or 25MΩ·μF min. (As for the capacitors of rated voltage 16V DC and lower, 500MΩ or 5MΩ·μF min.), whichever smaller.	Initial value setting Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.
15	Life	External appearance	No mechanical damage.	Test temp. : Maximum operating temperature ±2°C
		Capacitance	Change from the value before test	Applied voltage : Please contact with or sales representative.
			Please contact with our sales representative.	Test time: 1,000 +48,0h Charge/discharge current: 50mA or lowe Leave the capacitors in ambient condition
		D.F.	200% of initial spec. max.	for 24±2h before measurement.
		Insulation Resistance	1,000MΩ or 50MΩ·μF min. (As for the capacitors of rated voltage 16V DC and lower, 1,000MΩ or 10MΩ·μF min.), whichever smaller.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing. Initial value setting Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.

^{*}As for the initial measurement of capacitors on number 6,10,11,12 and 13, leave capacitors at 150 –10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.





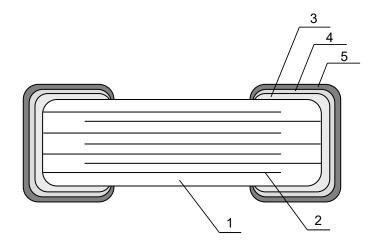
		(Uı	nit: mm)
Symbol Case size	а	b	С
C0510[CC0204]	0.2	0.6	1.0

1. Material : Glass Epoxy(As per JIS C6484 GE4)

2. Thickness: 1.6mm

Copper (Thickness: 0.035mm)
Solder resist

7. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL
1	Dielectric	BaTiO₃
2	Electrode	Nickel (Ni)
3	Termination	Copper (Cu)
4		Nickel (Ni)
5		Tin (Sn)

8. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

Tape packaging is as per 11. TAPE PACKAGING SPECIFICATION.

Information on label

- 1) Inspection No.*
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{5}$ \underline{A} $\underline{23}$ $\underline{001}$ (a) (b) (c) (d) (e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

(Implemented on and after May 1, 2019 in sequence)

- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day $(00 \sim ZZ)$
- (g) Suffix($00 \sim ZZ$)

Until the shift is completed, either current or new composition of inspection No. will be applied.

9. SOLDERING CONDITION

Reflow soldering only.

^{*}Composition of new Inspection No.

^{*} It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases.

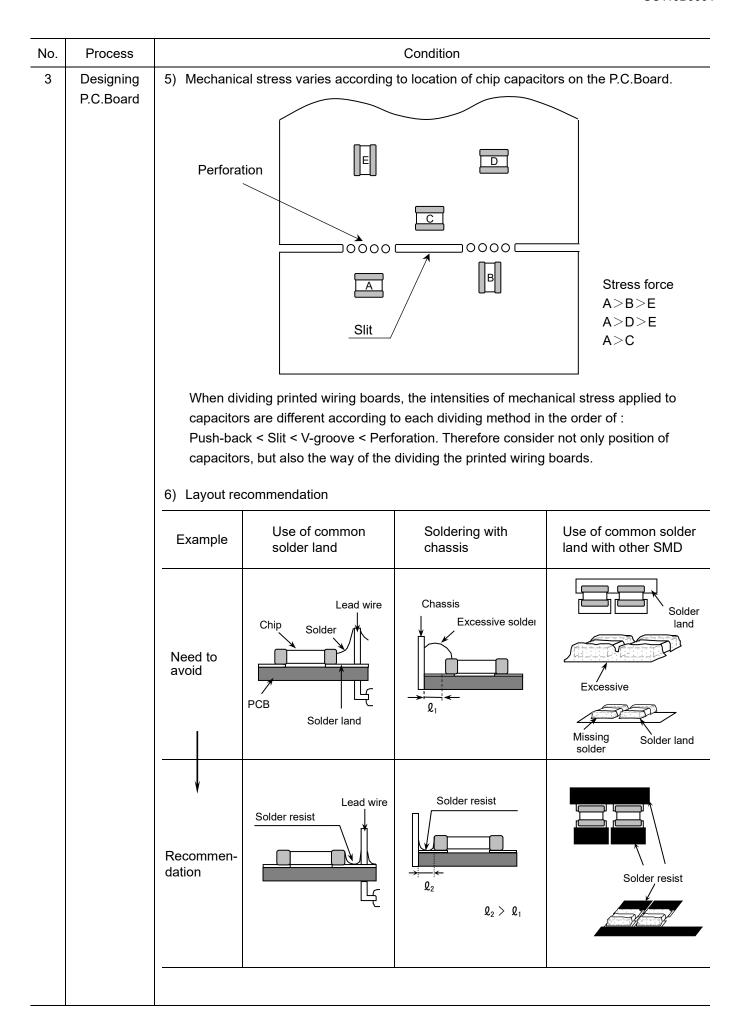
10. CAUTION

No.	Process	Condition
1	Operating	1-1. Storage, Use
	Condition (Storage, Use,	The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		 When capacitors are stored for a period longer than specified, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		1-2. Handling in transportation
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature
	<u> </u>	Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		Surface temperature including self heating should be below maximum operating temperature.
		Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board maerial and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C.
		When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)
		 The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.

No.	Process	Condition	
2	Circuit design	2-2. When overvoltage is applied	
	<u></u> Caution	Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature.	
		2-3. Operating voltage	
		 Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. — (1) and (2) 	
		AC or pulse with overshooting, V _{P-P} must be below the rated voltage. — (3), (4) and (5)	
	When the voltage is started to apply to the circuit or it is stopped applying irregular voltage may be generated for a transit period because of resona switching. Be sure to use the capacitors within rated voltage containing the Irregular voltage.		
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage	
		Positional Measurement (Rated voltage) Vo.P 0 Vo.P 0	
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)	
		Positional Measurement (Rated voltage)	
		Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.	
		 The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration. 	
		Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage.	
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.	
		2-4. Frequency When the capacitors are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.	

No.	Process		Condition
3	Designing P.C. Board	capacitor. 1) The greater the amount of and the more likely that it with the shape and size of the sterminations.	rminations has a direct effect on the reliability of the solder, the higher the stress on the chip capacitor, will break. When designing a P.C.Board, determine solder lands to have proper amount of solder on the er land for multiple terminations and provide ach terminations.
		3) Size and recommended la	nd dimensions.
		Cr	Solder land Solder resist
		Reflow soldering	(Unit : mm)
		Case size Symbol	C0510 [CC0204]
		A	0.2
		В	0.2
		С	1.0

No.	Process		Condition		
3	Designing P.C.Board	4) Recommended	1) Recommended chip capacitor layout is as following.		
			Disadvantage against bending stress	Advantage against bending stress	
			Perforation or slit	Perforation or slit	
		Mounting face			
			Break P.C.Board with mounted side up.	Break P.C.Board with mounted side down.	
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit Perforation or slit	Mount in parallel with perforation or slit Perforation or slit	
		Distance from slit	Closer to slit is higher stress $ \begin{array}{c c} & & & & \\ & & & & \\ & & & & \\ & & & & $	Away from slit is less stress $ \begin{array}{c c} & & & \\ & & & $	



No.	Process		Condition					
No. 4	Mounting	capacitor to resul 1) Adjust the botto surface and not 2) Adjust the mour 3) To minimize the	ead is adjusted too low, it may inc t in cracking. Please take followin m dead center of the mounting h	ead to reach on the P.C.Board I of static weight. ead, it is important to provide				
			Not recommended Recommended					
	mounting	Single-sided mounting	Crack	A support pin is not to be underneath the capacitor.				
		Double-sides mounting	Solder peeling Crack	Support pin				
		to cause crack. Pl	ng jaw is worn out, it may give me ease control the close up dimens preventive maintenance and repla					

No.	Process	Condition					
5	Soldering	 5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 2) Excessive flux must be avoided. Please provide proper amount of flux. 3) When water-soluble flux is used, enough washing is necessary. 5-2. Recommended soldering profile: Reflow method Refer to the following temperature profile at Reflow soldering. 					
		Reflow soldering					
		Soldering					
		Natural cooling					
		Peak Temp O O O O O O O O O O O O O O O O O O					
		5-3. Recommended soldering peak temp and peak temp duration for Reflow soldering Pb free solder is recommended, but if Sn-37Pb must be used, refer to below.					
		Temp./Duration Reflow soldering					
		Solder Peak temp(°C) Duration(sec.)					
		Lead Free Solder 260 max. 10 max.					
		Sn-Pb Solder 230 max. 20 max.					
		Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu					

No.	Process		Condition			
5	Soldering	5-4. Avoiding thermal shock				
		Preheating condition				
		Soldering	Temp. (°C)			
		Reflow soldering	ΔT ≦ 150			
		2) Cooling condition Natural cooling using air is re cleaning, the temperature di 5-5. Amount of solder Excessive solder will induce temperature changes and it detach the capacitors from	fference (∆T) must be les e higher tensile force in ch t may result in chip cracki	nip capacitors when		
		Excessive solder		Higher tensile force in chip capacitors to cause crack		
		Adequate		mum amount num amount		
		Insufficient solder		Low robustness may cause contact failure or chip capacitors come off the P.C.board.		
		5-6. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-7. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative) Recommendations to prevent the tombstone phenomenon)				

No.	Process		Condit	ion					
6	Solder repairing	Solder repairing is unavoidable, refer to below. 6-1. Solder repair by solder iron 1) Selection of the soldering iron tip							
		Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However,							
		heat shock may caus			No				
		Please make sure th time in accordance w		-	ine peak temp and				
			Manual s	•					
		Peak Temp (C). (C)	(Solder	r Iron)					
		0	3sec. (As short as possible)						
		Recommended s	older iron condition	(Sn-Pb Solder and	Lead Free Solder)				
		Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)				
		350 max.	3 max.	20 max.	∅ 3.0 max.				
		· ·	* Please preheat the chip capacitors with the condition in 6-2 to avoid the thermal shock.						
		 Direct contact of the soldering iron with ceramic dielectric of chip cause crack. Do not touch the ceramic dielectric and the termina iron. 							
	3) It is not recommended to reuse dismounted capacitors.								
		6-2. Avoiding thermal sho	ck						
		Preheating condition							
		Soldering	Soldering Temp. (°C)						
		Manual solder	ing $\Delta T \leq 15$	50					

No.	Process	Condition
7	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning equipment is used, excessive ultrasonic power or direct vibration transfer to a printed wiring board may generate a resonant vibration in the board. This may cause a crack in a capacitor or its solder joints to the board and degradation in the terminal strength of the capacitor. In order to avoid this, the following cleaning conditions are recommended.
		Power : 20 W/l max.
		Frequency : 40 kHz max. Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
8	Coating and	1) When the P.C.board is coated, please verify the quality influence on the product.
	molding of the P.C.board	Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.
		3) Please verify the curing temperature.
9	Handling after chip mounted	Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack. Bend Twist

	T								
No.	Process	Condition							
9	Handling after	2) Printed circuit board cropping should not be carried out by hand, but by using the							
	chip mounted	proper tooling. Printed circuit board cropping should be carried out using a board							
	<u> </u>	cropping jig as shown in the following figure or a board cropping apparatus to							
		prevent inducing mechanical stress on the board.							
		(1) Example of a board cropping jig Recommended example: The board should be pushed from the back side close to the cropping jig so that the board is not bent and the stress applied the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig a the pushing direction is from the front side of the board, large tensile stress applied to the capacitor, which may cause cracks.							
		Outline of jig Recommended Unrecommended							
		Printed circuit board Board cropping jig V-groove Slot Direction of load Load point Printed circuit board V-groove Slot Slot Slot Direction of load Load point V-groove Slot Slot Slot Slot Direction of load V-groove Slot Sl							
		(2) Example of a board cropping machine							
		An outline of a printed circuit board cropping machine is shown below. The							
		top and bottom blades are aligned with one another along the lines with the V-grooves on printed circuit board when cropping the board.							
		v-grooves on printed circuit board when cropping the board. Unrecommended example: Misalignment of blade position between top and							
		bottom, right and left, or front and rear blades may cause a crack in the							
		capacitor.							
		Outline of machine Principle of operation Top blade							
		Top blade Printed circuit board 0							
		V-groove Bottom blade							
		Printed circuit board							
		Cross-section diagram Top blade							
		Printed circuit board							
		V-groove Bottom blade							
		Recommended Unrecommended							
		Top-bottom Left-right Front-rear misalignment misalignment							
		Top blade							
		Top blade Top blade Top blade							
		Board							
		Bottom blade Bottom blade Bottom blade Bottom blade							

No.	Process		Condition			
9	Handling after chip mounted	to be adj	en functional check of the P.C.board is performed, check pin pressure tends e adjusted higher for fear of loose contact. But if the pressure is excessive bend the P.C.board, it may crack the chip capacitors or peel the ninations off. Please adjust the check pins not to bend the P.C.board.			
		Item	Not recommended	Recommended		
		Board bending	Termination peeling Check pin	Support pin Check pin		
10	Handling of loose chip capacitors					
11	Capacitance aging	· -	s have aging in the capacitance. The circuit. In case of the time constant	· ·		
12	Estimated life and estimated failure rate of capacitors	and the voltage RCR-2335C A estimated failure The failure rate	timated life and the estimated failure ge. This can be calculated by the equation of the equation of the equation of the equation of the equation coefficient (Voltage acceleration coefficient 10°C rule) the can be decreased by reducing the equaranteed.	uation described in JEITA f the estimated lifetime and the ficient : 3 multiplication rule,		

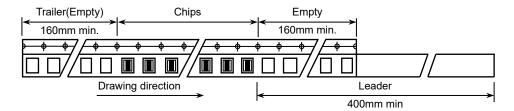
No.	Process	Condition
13	Caution during operation of equipment	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		 Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. Environment where a capacitor is spattered with water or oil Environment where a capacitor is exposed to direct sunlight Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation Environment where a capacitor exposed to corrosive gas (e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. Atmosphere change with causes condensation
13	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment
		(12) Safety equipment (13) Other applications that are not considered general-purpose applications
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

11. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape Dimensions of paper tape shall be according to Appendix 3.

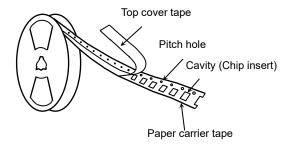
1-2. Empty part and leader of taping



1-3. Dimensions of reel

Dimensions of \emptyset 178 reel shall be according to Appendix 4. Dimensions of \emptyset 330 reel shall be according to Appendix 5.

1-4. Structure of taping

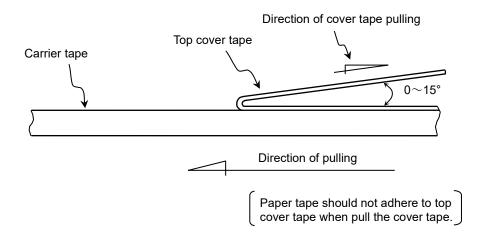


2. CHIP QUANTITY

Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

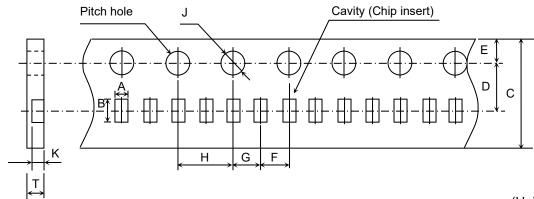
3-1. Fixing peeling strength (top tape)0.05N < Peeling strength < 0.7N



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

Appendix 3

Paper Tape



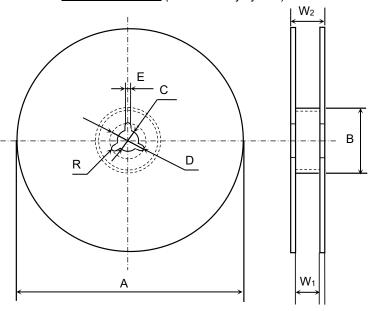
(Unit: mm)

Symbol	А	В	С	D	E	F
Dimension	(0.62)	(1.12)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05
Symbol	G	Н	J	К	Т	•
Dimension	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 ^{+0.1} 0	(0.38)	0.50 max.	•

^() Referenced value.

Appendix 4

<u>Dimensions of reel</u> (Material: Polystyrene)



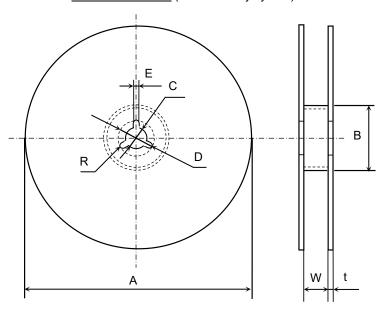
(Unit: mm)

Dimension Ø 178±2.0 Ø 60±2.0 Ø 13±0.5 Ø 21±0.8 2.0±0.5 9.0±0.3	Symbol	Α	В	С	D	E	W_1
	Dimension	ø 178±2.0	ø 60±2.0	ø 13±0.5	ø 21±0.8	2.0±0.5	9.0±0.3

Symbol	W ₂	R
Dimension	13.0 ± 1.4	1.0

Appendix 5

<u>Dimensions of reel</u> (Material: Polystyrene)



(Unit: mm)

Symbol	Α	В	С	D	Е	W
Dimension	ø 382 max. (Nominal ø 330)	ø 50 min.	ø 13±0.5	ø 21±0.8	2.0±0.5	10.0±1.5

Symbol	t	R
Dimension	2.0±0.5	1.0